

Notice of References CitedApplication/Control No.
09/880,371Applicant(s)/Patent Under
Reexamination
WEI ET AL.Examiner
Anne R. KubelikArt Unit
1638

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	N	WO 99/07206	02-1999	WIPO	Bogdanove et al	-
	O	WO 98/24297	06-1998	WIPO	Qiu et al	-
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	U	Preston et al, 1995, Mol. Plant-Microbe Interact. 8:717-732
	V	Bonas, 1994, Current Topics in Microbiology and Immunology 192:79-98
	W	Bonas, 1994, Trends Microbiol. 2:1-2
	X	Dong et al, 1999, Plant J. 20:207-215

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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